

## **CLAIMS**

What is claimed is:

1. A method comprising:

    sending an electronic license to enable a device tester;  
    receiving at least one log file having resource use information for one or more tests executed on the device tester using the electronic license;  
    generating a bill from the at least one log file.

2. The method of claim 1, further comprising after a predetermined period of time, renewing the license by sending a second electronic license to enable the device tester.

3. The method of claim 1, further comprising sending a second electronic license to increase a resource allotment of the device tester.

4. The method of claim 3, wherein the resource allotment comprises an amount of memory available on the device tester.

5. The method of claim 3, wherein the resource allotment comprises a speed available on the device tester.

6. The method of claim 3, wherein the resource allotment comprises a number of waveforms available on the device tester.

7. The method of claim 3, wherein the resource allotment comprises a number of edge transitions available in a clock cycle.

8. A method comprising:

    creating at least one log file having resource use information for one or more tests executed on a device tester; and  
    generating a usage report based on the at least one log file.

9. The method of claim 8, further comprising creating a bill using the usage report.
10. The method of claim 8, wherein the resource use information includes memory used to execute the one or more tests.
11. The method of claim 8, wherein the resource use information includes speed used to execute the one or more tests.
12. The method of claim 8, wherein the at least one log file includes a user name associated with the one or more tests executed on the device tester.
13. The method of claim 6, wherein the device tester comprises a system-on-a-chip (SOC) tester.
14. A system comprising:
  - a tester to apply one or more tests to a device; and
  - logic, communicatively coupled to the tester, to enable one or more resources of the tester according to one or more properties of an electronic license and to create at least one log file having resource use information for one or more tests executed on the tester.
15. The system of claim 14, wherein the logic is to enable an amount of memory available on the tester according to one of the properties of the electronic license.
16. The system of claim 14, wherein the logic is to enable a speed available on the tester according to one of the properties of the electronic license.
17. The system of claim 14, wherein the logic is to enable a number of waveforms available on the tester according to one of the properties of the electronic license.

18. The system of claim 14, wherein the logic is to enable a number of edge transitions available on the tester according to one of the properties of the electronic license.

19. The system of claim 14, wherein the tester comprises a system-on-a-chip (SOC) tester.